

<b>Notice of References Cited</b>	Application/Control No. 10/528,754		Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner TAI DUONG		Art Unit 2871	Page 1 of 1

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*	B	US-7,038,746	05-2006	Tominaga et al.	349/96
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	M	US-			

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**NON-PATENT DOCUMENTS**

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